Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,089	GLASS ET AL.	
Examiner	Art Unit	
Michael I Eeely	1712	

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
Inventor Search on Palm, eDan, Éast	1/31/2006	MF
Limited Class Search on East of: 523/400,402,414,417,436; 525/523,526,540; 507/219,239,242,244,246	1/31/2006	MF
Limited Class Search on East of: 528/87,88,106,119,120,121,122,403,4 19,421,422,423)	1/31/2006	MF
Text Search on East (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB)	1/31/2006	MF
Above updated: 1/1/07		MF